

**ESD protected Dual N-channel MOSFET**

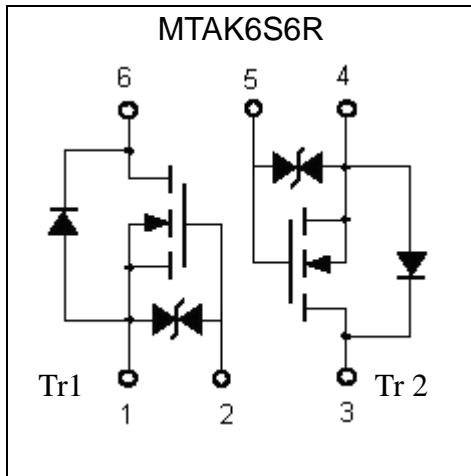
# MTAK6S6R

|                                     |                          |              |
|-------------------------------------|--------------------------|--------------|
| $BV_{DSS}$                          | 60V                      |              |
| $I_D @ V_{GS}=4.5V, T_A=25^\circ C$ | 250mA                    |              |
| $R_{DS(on)(TYP)}$                   | $V_{GS}=4.5V, I_D=200mA$ | 1.3 $\Omega$ |
|                                     | $V_{GS}=2.5V, I_D=100mA$ | 1.7 $\Omega$ |

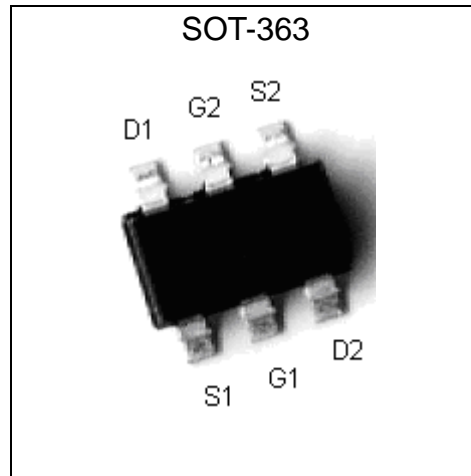
**Description**

- Low voltage drive(2.5V drive) makes this device ideal for portable equipment.
- The MOSFET elements are independent, eliminating mutual interference.
- Mounting cost and area can be cut in half.
- High speed switching
- ESD protected device,  $HBM \geq 2kV$
- Pb-free lead plating & halogen-free package

**Symbol**

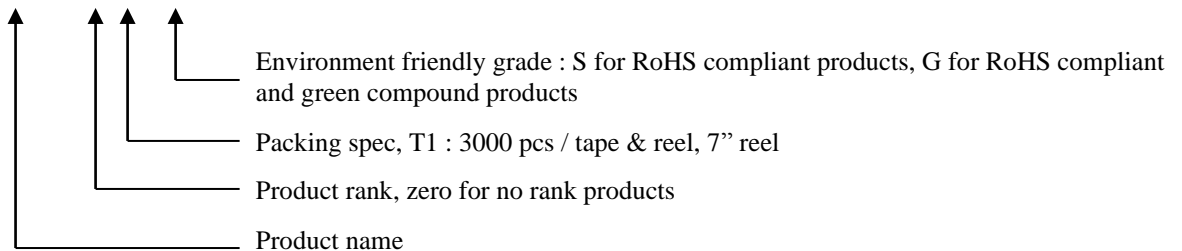


**Outline**



**Ordering Information**

| Device          | Package  | Shipping               |
|-----------------|--|------------------------|
| MTAK6S6R-0-T1-G | SOT-363<br>(Pb-free lead plating & halogen-free package) | 3000 pcs / Tape & Reel |





**The following characteristics apply to both Tr1 and Tr2**  
**Absolute Maximum Ratings (Ta=25°C)**

| Parameter  | Symbol                            | Limits   | Unit |
|--|-----------------------------------|----------|------|
| Drain-Source Voltage                             | BV <sub>DSS</sub>                 | 60       | V    |
| Gate-Source Voltage                              | V <sub>GS</sub>                   | ±16      |      |
| Continuous Drain Current                         | I <sub>D</sub>                    | 250      | mA   |
| Pulsed Drain Current                             | I <sub>DM</sub>                   | 800 *1   |      |
| Total Power Dissipation                          | P <sub>D</sub>                    | 200 *2   | mW   |
| ESD susceptibility                               | V <sub>ESD</sub>                  | 2000 *3  | V    |
| Operating Junction and Storage Temperature Range | T <sub>j</sub> ; T <sub>stg</sub> | -55~+150 | °C   |

Note : \*1. Pulse Width ≤ 10μs, Duty cycle ≤ 1%  
 \*2. With each pin mounted on the recommended lands.  
 \*3. Human body model, 1.5kΩ in series with 100pF

**Thermal Data**

| Parameter                                   | Symbol                | Value             | Unit |
|---|-----------------------|-------------------|------|
| Thermal Resistance, Channel-to-ambient, max | *R <sub>th,ch-a</sub> | 625 (total)       | °C/W |
|   |                       | 800 (per element) |      |

Note : With each pin mounted on the recommended lands.

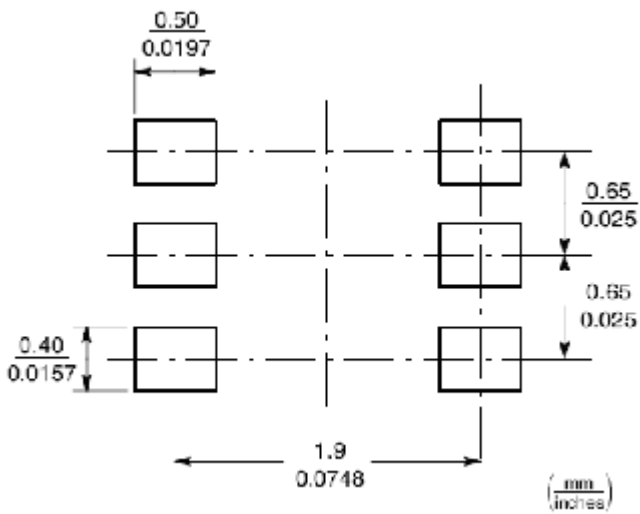
**Electrical Characteristics (Ta=25°C)**

| Symbol              | Min. | Typ. | Max. | Unit | Test Conditions  |
|---------------------|------|------|------|------|--|
| <b>Static</b>       |      |      |      |      |  |
| BV <sub>DSS</sub>   | 60   | -    | -    | V    | V <sub>GS</sub> =0V, I <sub>D</sub> =250μA   |
| V <sub>GS(th)</sub> | 0.5  | -    | 1.5  |      | I <sub>D</sub> =250μA, V <sub>DS</sub> =V <sub>GS</sub>                                |
| I <sub>GSS</sub>    | -    | -    | ±10  | μA   | V <sub>GS</sub> =±16V, V <sub>DS</sub> =0V   |
| I <sub>DSS</sub>    | -    | -    | 1    |      | V <sub>DS</sub> =60V, V <sub>GS</sub> =0V  |
| R <sub>DS(ON)</sub> | -    | 1.3  | 3    | Ω    | V <sub>GS</sub> =4.5V, I <sub>D</sub> =200mA   |
|                     | -    | 1.7  | 5.1  |      | V <sub>GS</sub> =2.5V, I <sub>D</sub> =100mA   |
| G <sub>FS</sub>     | 100  | 322  | -    | mS   | V <sub>DS</sub> =5V, I <sub>D</sub> =100mA   |
| <b>Dynamic</b>      |      |      |      |      |  |
| C <sub>iss</sub>    | -    | 25.6 | -    | pF   | V <sub>DS</sub> =30V, V <sub>GS</sub> =0V, f=1MHz                                      |
| C <sub>oss</sub>    | -    | 8.8  | -    |      |  |
| C <sub>rss</sub>    | -    | 6.8  | -    |      |  |
| t <sub>d(on)</sub>  | -    | 5.8  | -    | ns   | V <sub>DD</sub> =30V, I <sub>D</sub> =200mA, V <sub>GS</sub> =10V, R <sub>G</sub> =25Ω |
| t <sub>r</sub>      | -    | 0.8  | -    |      |  |
| t <sub>d(off)</sub> | -    | 19   | -    |      |  |
| t <sub>f</sub>      | -    | 1.4  | -    |      |  |
| Q <sub>g</sub>      | -    | 0.82 | -    | nC   | I <sub>D</sub> =0.5A, V <sub>DS</sub> =48V, V <sub>GS</sub> =4.5V                      |
| Q <sub>gs</sub>     | -    | 0.34 | -    |      |  |
| Q <sub>gd</sub>     | -    | 0.2  | -    |      |  |

| Source-Drain Diode |   |      |     |    |   |
|--------------------|---|------|-----|----|---|
| *V <sub>SD</sub>   | - | 0.74 | 1.2 | V  | V <sub>GS</sub> =0V, I <sub>S</sub> =100mA<br>I <sub>F</sub> =0.5A, dI <sub>F</sub> /dt=100A/μs |
| *trr               | - | 8.2  | -   | ns |   |
| *Qrr               | - | 2.3  | -   | nC |   |

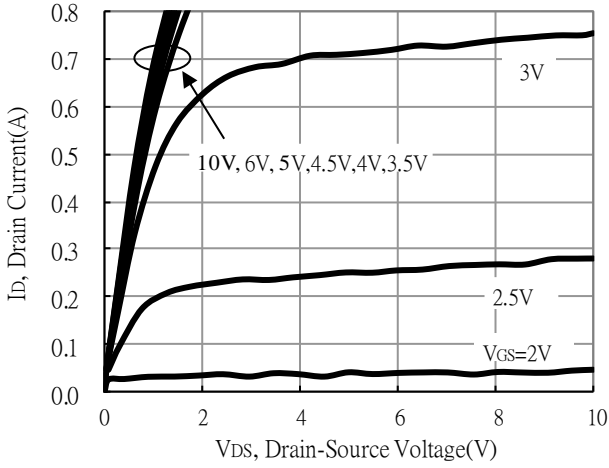
\*Pulse Test : Pulse Width ≤300μs, Duty Cycle≤2%

### Recommended Soldering Footprint

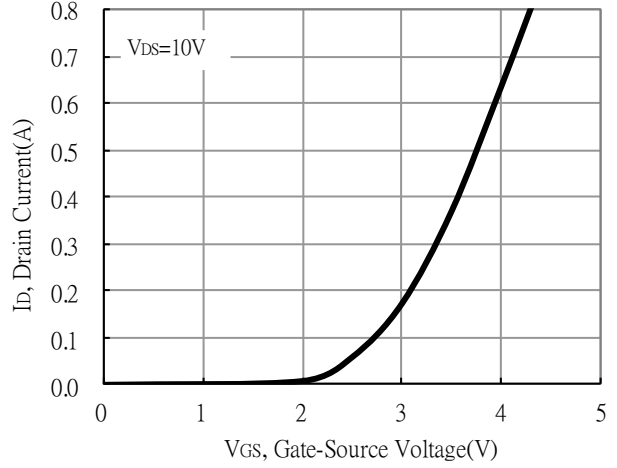


## Typical Characteristics

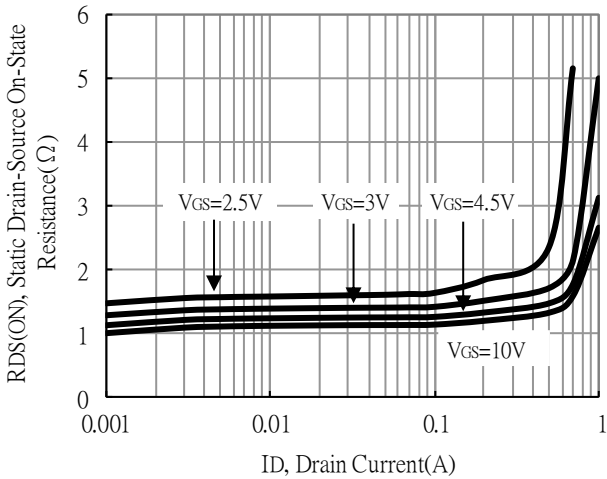
Typical Output Characteristics



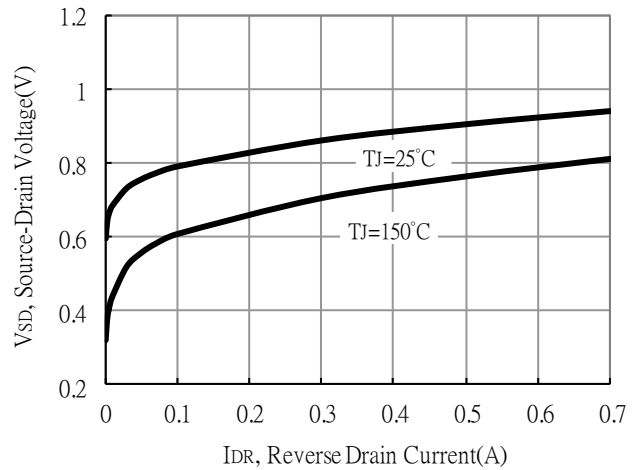
Typical Transfer Characteristics



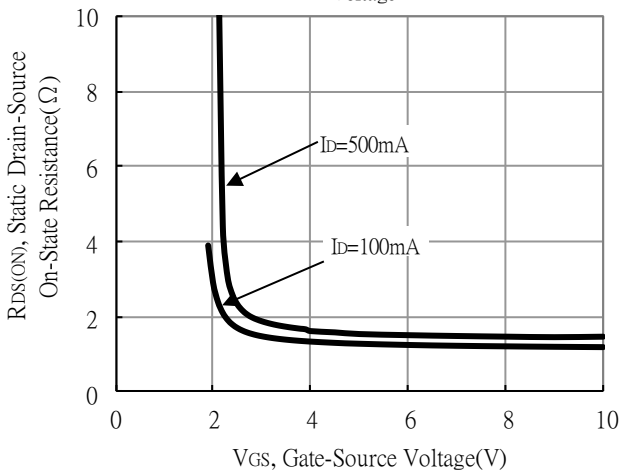
Static Drain-Source On-State resistance vs Drain Current



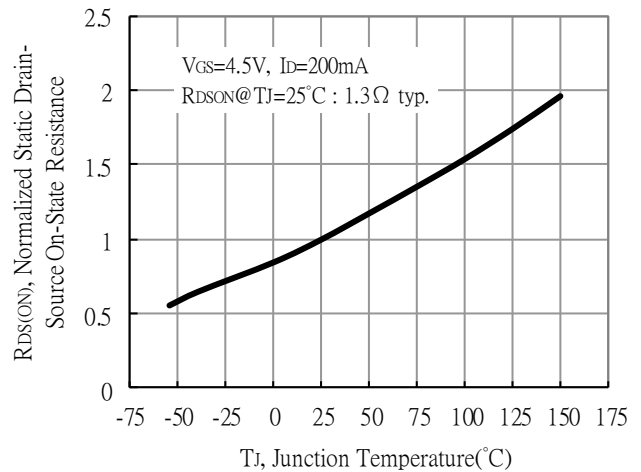
Reverse Drain Current vs Source-Drain Voltage



Static Drain-Source On-State Resistance vs Gate-Source Voltage

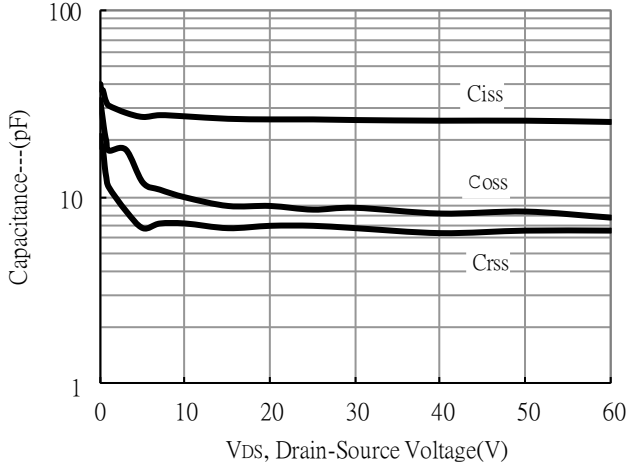


Drain-Source On-State Resistance vs Junction Temperature

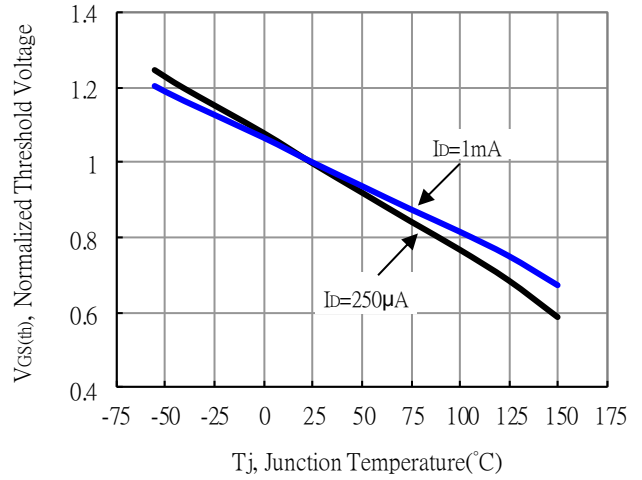


**Typical Characteristics(Cont.)**

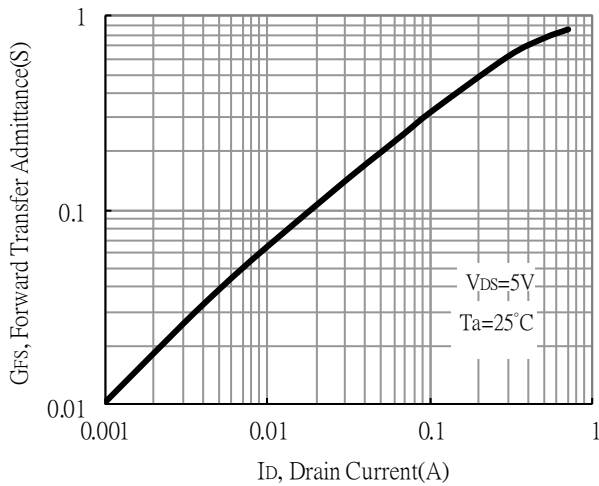
Capacitance vs Drain-to-Source Voltage



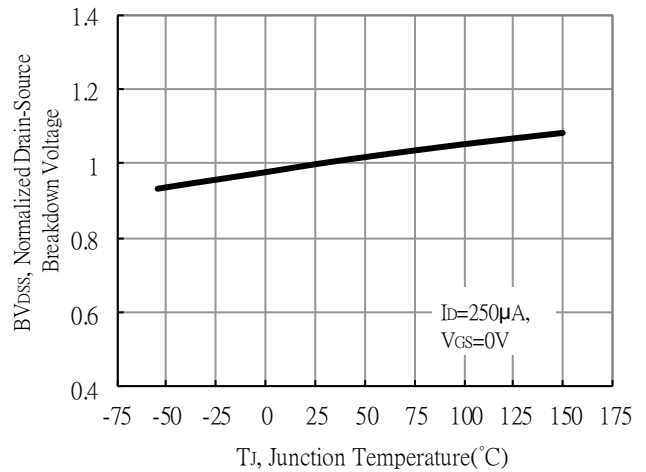
Threshold Voltage vs Junction Temperature



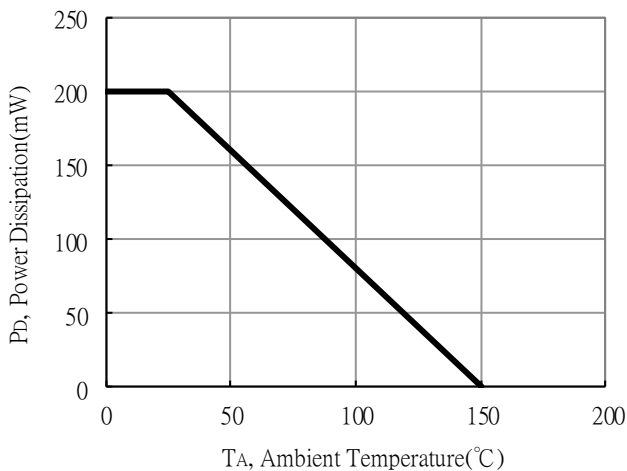
Forward Transfer Admittance vs Drain Current



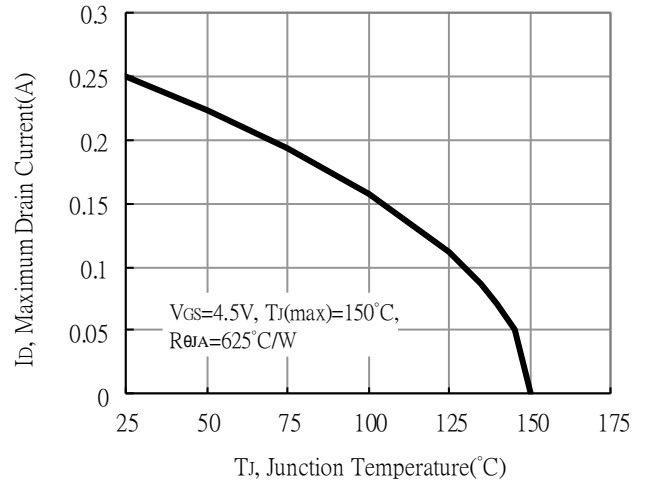
Brekdown Voltage vs Ambient Temperature



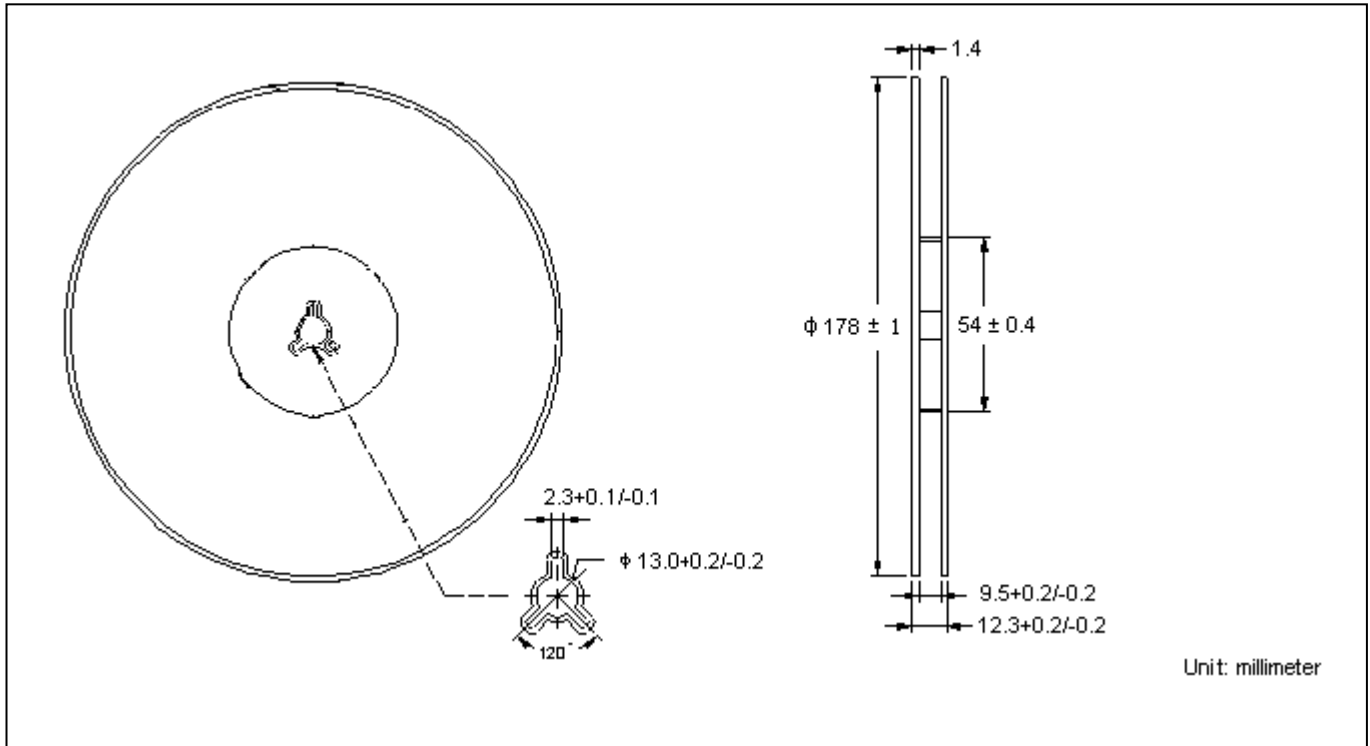
Power Derating Curve



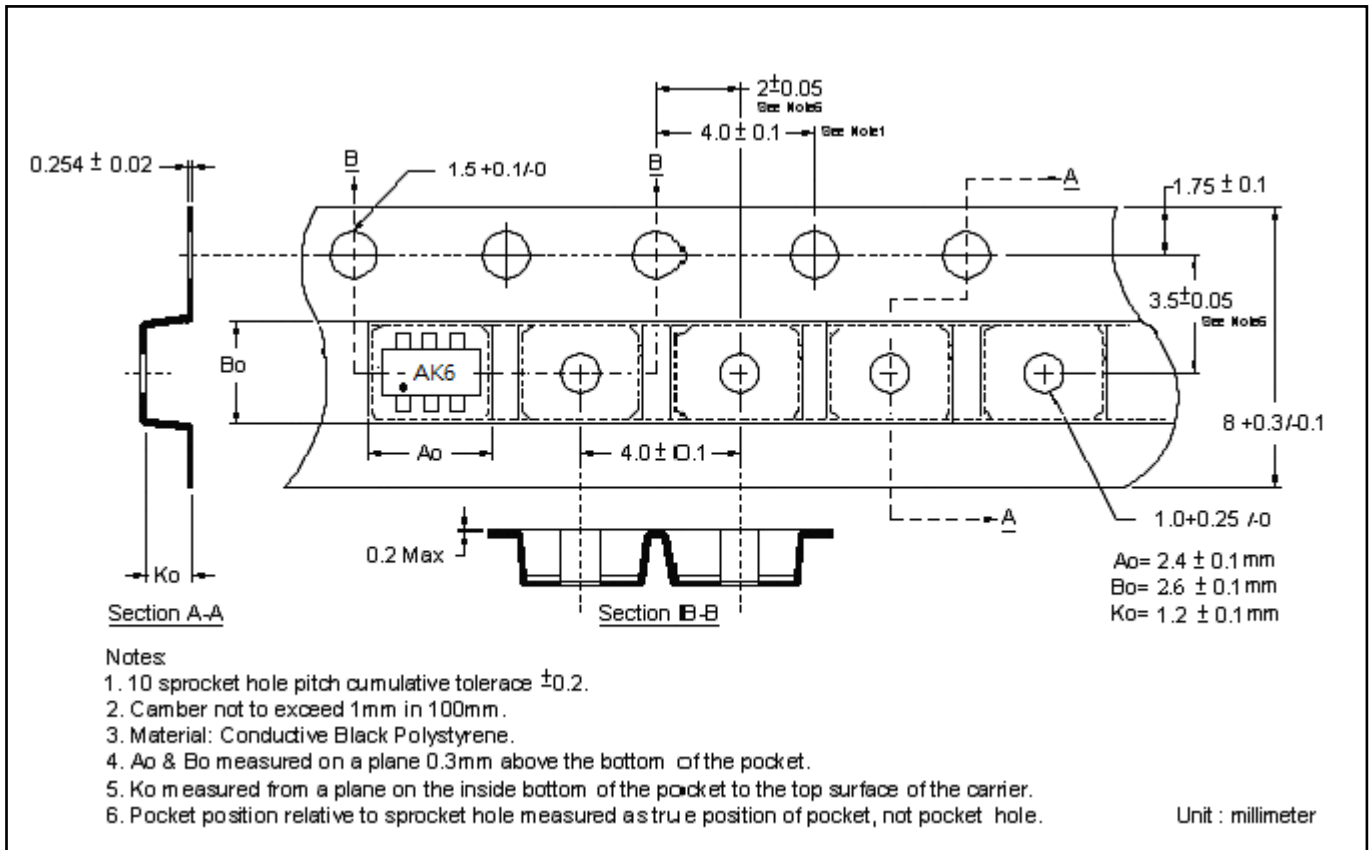
Maximum Drain Current vs Junction Temperature



**Reel Dimension**



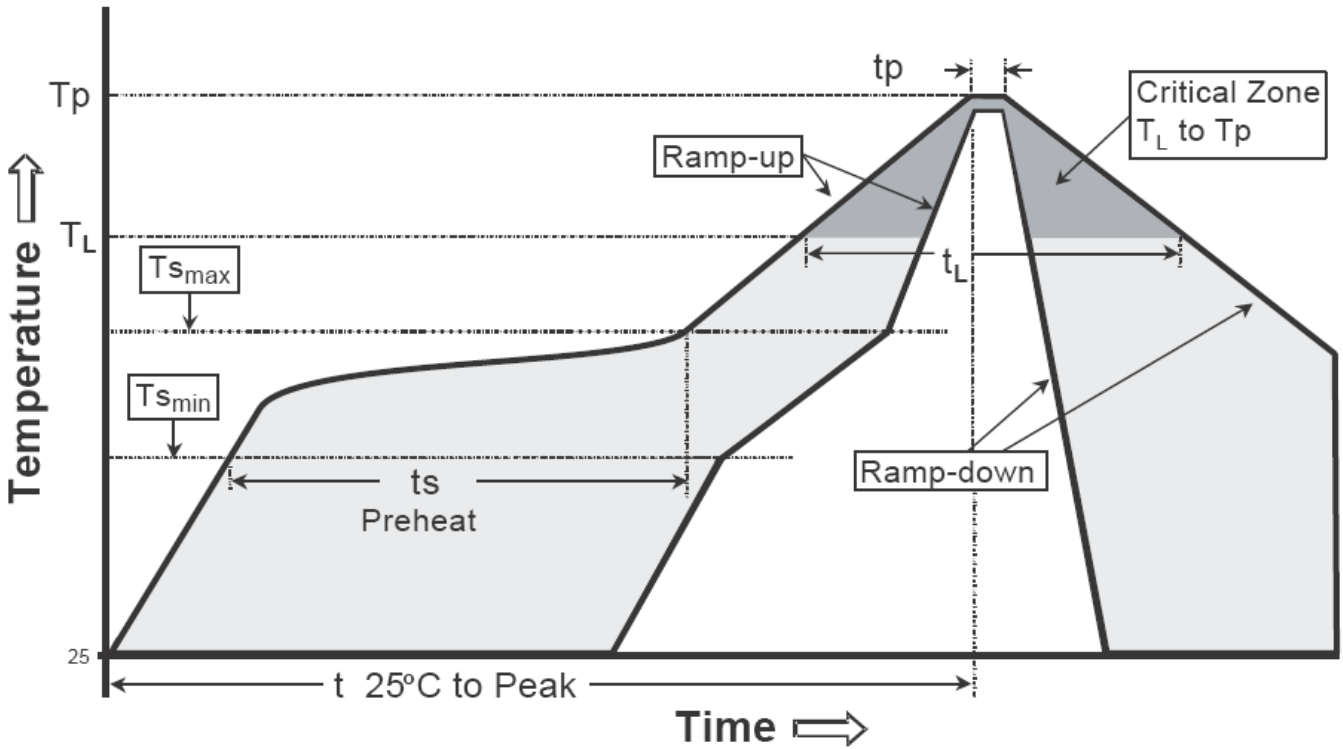
**Carrier Tape Dimension**



**Recommended wave soldering condition**

|                 |                  |                 |
|-----------------|------------------|-----------------|
| Product         | Peak Temperature | Soldering Time  |
| Pb-free devices | 260 +0/-5 °C     | 5 +1/-1 seconds |

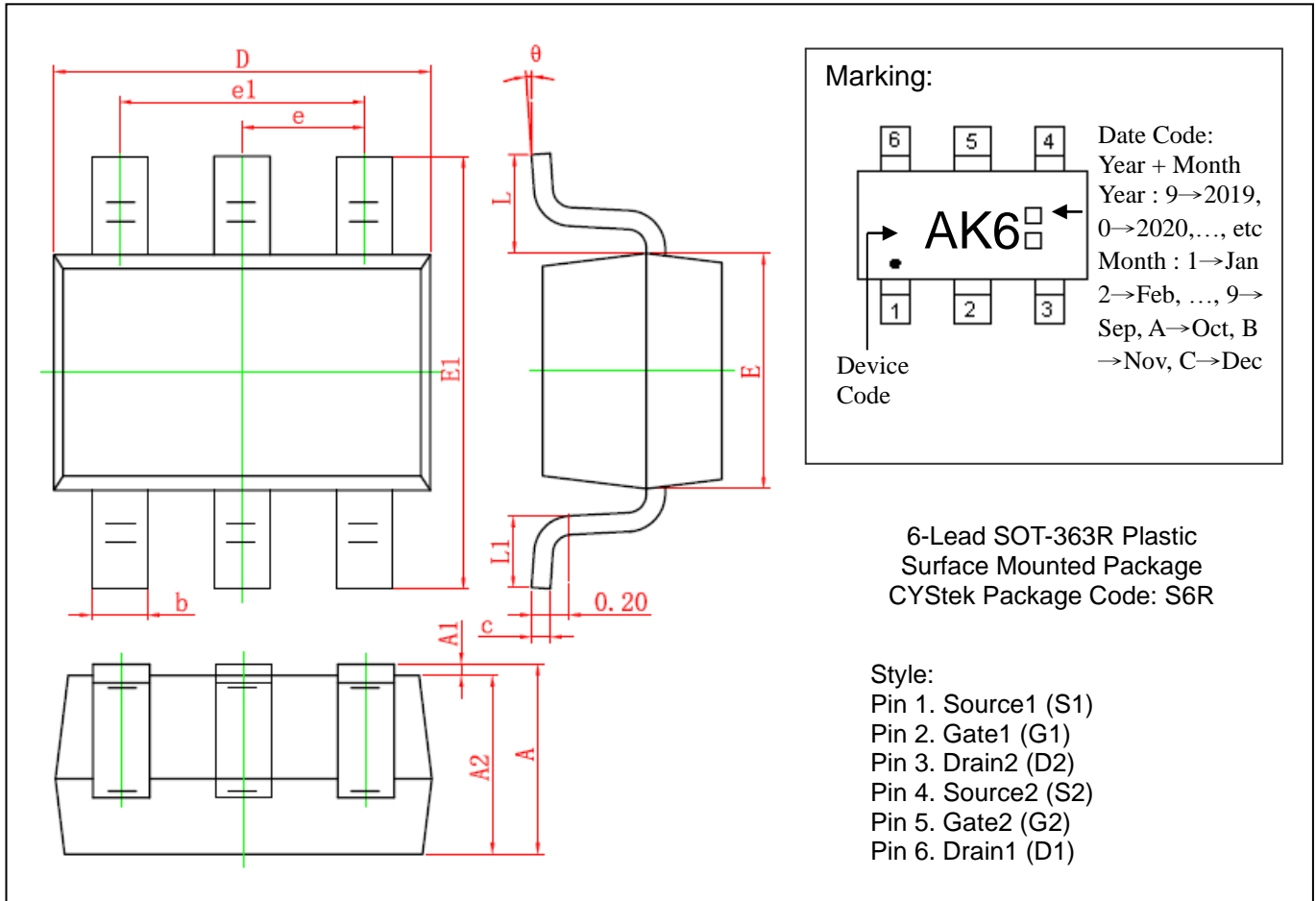
**Recommended temperature profile for IR reflow**



| Profile feature   | Sn-Pb eutectic Assembly | Pb-free Assembly |
|---|-------------------------|------------------|
| Average ramp-up rate (T <sub>smax</sub> to T <sub>p</sub> ) | 3°C/second max.         | 3°C/second max.  |
| Preheat   |                         |                  |
| -Temperature Min(T <sub>s min</sub> )                       | 100°C                   | 150°C            |
| -Temperature Max(T <sub>s max</sub> )                       | 150°C                   | 200°C            |
| -Time(t <sub>s min</sub> to t <sub>s max</sub> )            | 60-120 seconds          | 60-180 seconds   |
| Time maintained above:                                      |                         |                  |
| -Temperature (T <sub>L</sub> )                              | 183°C                   | 217°C            |
| - Time (t <sub>L</sub> )                                    | 60-150 seconds          | 60-150 seconds   |
| Peak Temperature(T <sub>P</sub> )                           | 240 +0/-5 °C            | 260 +0/-5 °C     |
| Time within 5°C of actual peak temperature(tp)              | 10-30 seconds           | 20-40 seconds    |
| Ramp down rate  | 6°C/second max.         | 6°C/second max.  |
| Time 25 °C to peak temperature                              | 6 minutes max.          | 8 minutes max.   |

Note : All temperatures refer to topside of the package, measured on the package body surface.

**SOT-363 Dimension**



| DIM | Millimeters |       | Inches |       | DIM | Millimeters |       | Inches |       |
|-----|-------------|-------|--------|-------|-----|-------------|-------|--------|-------|
|     | Min.        | Max.  | Min.   | Max.  |     | Min.        | Max.  | Min.   | Max.  |
| A   | 0.900       | 1.100 | 0.035  | 0.043 | E1  | 2.150       | 2.450 | 0.085  | 0.096 |
| A1  | 0.000       | 0.100 | 0.000  | 0.004 | e   | 0.650       | TYP   | 0.026  | TYP   |
| A2  | 0.900       | 1.000 | 0.035  | 0.039 | e1  | 1.200       | 1.400 | 0.047  | 0.055 |
| b   | 0.150       | 0.350 | 0.006  | 0.014 | L   | 0.525       | REF   | 0.021  | REF   |
| c   | 0.080       | 0.150 | 0.003  | 0.006 | L1  | 0.260       | 0.460 | 0.010  | 0.018 |
| D   | 2.000       | 2.200 | 0.079  | 0.087 | θ   | 0°          | 8°    | 0°     | 8°    |
| E   | 1.150       | 1.350 | 0.045  | 0.053 |     |             |       |        |       |

Notes : 1.Controlling dimension : millimeters.  
 2.Maximum lead thickness includes lead finish thickness, and minimum lead thickness is the minimum thickness of base material.  
 3.If there is any question with packing specification or packing method, please contact your local CYStek sales office.

**Material :**

- Lead : Pure tin plated.
- Mold Compound : Epoxy resin family, flammability solid burning class:UL94V-0.

**Important Notice:**

- All rights are reserved. Reproduction in whole or in part is prohibited without the prior written approval of CYStek.
- CYStek reserves the right to make changes to its products without notice.
- CYStek **semiconductor products are not warranted to be suitable for use in Life-Support Applications, or systems.**
- CYStek assumes no liability for any consequence of customer product design, infringement of patents, or application assistance.